Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/772,435	SHIRAISHI ET AL.
Examiner	Art Unit
John L. Goodrow	1756

	SEARCHED				
Class	Subclass	Date	Examiner		
430	109.4	4/17/2006	JG		
	108.6				
	120				
	·				
	_				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	• • •			
			-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
	İ	
		-
		İ
		-